

Stability of perpendicular anisotropy in NiFe/Au/Co/Au multilayers[☆]

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Abstract

The influence of annealing on a giant magnetoresistance, magnetization reversal, and microstructure of magnetron sputtered spin valve [NiFe/Au/Co/Au]₁₀ multilayers (MLs) consisting of ferromagnetic layers with alternating in-plane (NiFe) and out-of-plane (Co) magnetic anisotropy has been investigated. It is shown that properties of the MLs are relatively stable against annealing up to 263 °C and are primarily influenced by mixing at Au/Co interfaces. The MLs with thicker Co layers are more stable.

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1. Introduction

Magnetic layered structures with alternating in-plane and out-of-plane anisotropy in neighboring magnetic layers, separated by nonmagnetic spacer, were shown to possess properties interesting from an application point of view [1–5]. In particular, it was demonstrated that [NiFe/Au/Co/Au]_N multilayers display giant magnetoresistance (GMR) [1] and that their magnetic and magnetoresistive properties can be modified in a broad range by adjusting layers thicknesses [1] and/or using composite magnetic layers [2]. It was also shown that they are resistant to low temperature annealings [3] and display satisfactory temperature stability [4]. The aim of this study is to explain the observed changes of magnetic properties of [NiFe/Au/Co/Au]₁₀ MLs under the influence of high temperature annealings and to determine Co thickness range assuring the high thermal stability.

2. Experimental

The [Ni₈₀Fe₂₀(2 nm)/Au(1.9 nm)/Co(*t*_{Co})/Au(1.9 nm)]₁₀ MLs with *t*_{Co} = 0.6–1.2 nm were deposited in Ar atmosphere using UHV magnetron sputtering. The films were deposited directly onto Si(1 0 0) substrates with native oxide. The sputtering rates were 0.06, 0.05, and 0.045 nm/s, for Au, NiFe and Co, respectively. The microstructure was investigated using low and high angle

X-ray diffraction (LAXRD and HAXRD) with Cu Kα radiation. The magnetization reversal processes were studied at room temperature with a vibrating sample magnetometer (VSM). Current in-plane magnetoresistance was measured at RT in a four-point configuration. Magnetic fields up to 1600 kA/m (2 T), applied in-plane and perpendicularly, were used. The MR(*H*) dependence was calculated relative to the resistance at 1600 kA/m and the maximum value determined from MR(*H*) is called magnetoresistance (MR) amplitude throughout the text. The samples were cumulatively annealed in gas flow thermostat in dry N₂ in temperatures (*T*_A) up to 300 °C. Each annealing lasted 1 h.

3. Results and discussion

As was already shown [3] the MR amplitude in NiFe/Au/Co/Au MLs is not changed by annealings at *T*_A ≤ 250 °C. Annealings at higher temperatures (*T*_A = 300 °C) lead to a strong degradation of the MR effect (Fig. 1). Exemplary *M*(*H*) dependencies indicate that annealings at *T*_A ≤ 263 °C modify the magnetization reversal processes of Co layers (Fig. 1) but do not result in the change of the anisotropy direction from out-of-plane (the anisotropy changes are discussed later). For magnetic field applied perpendicularly annealings result in the changes of nucleation (*H*_N) and domain annihilation (*H*_A) fields [3]. The values of this fields are significantly lower, however, than the shape anisotropy saturation field of NiFe layers (*H*_S^{NiFe} = *M*_S^{NiFe}) and thus Co layers influence directly the MR(*H*) only in limited field range: |*H*| < *H*_N, *H*_A ≪ *H*_S^{NiFe} [6]. That is the reason why MR amplitude does not change significantly for *T*_A ≤ 263 °C (Fig. 2).

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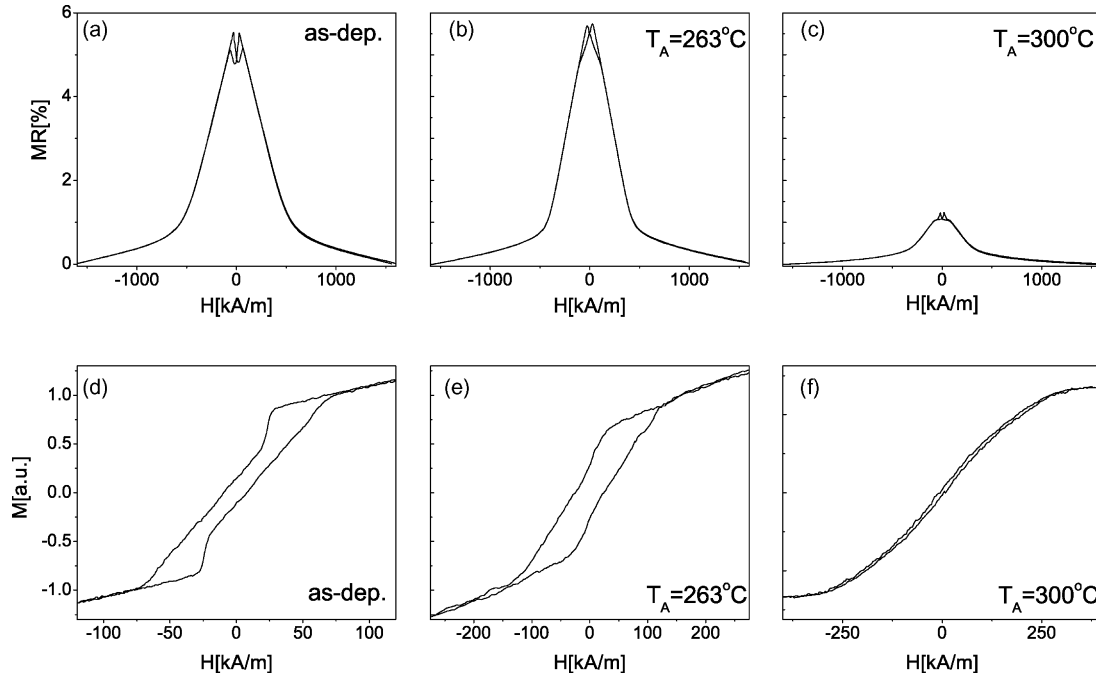


Fig. 1. Magnetoresistance (upper panels) and magnetization reversal curves of $[\text{Ni}_{80}\text{Fe}_{20}(2\text{ nm})/\text{Au}(1.9\text{ nm})/\text{Co}(0.6\text{ nm})/\text{Au}(1.9\text{ nm})]_{10}$ ML at different stages of the thermal treatment. The dependencies were measured with magnetic field applied perpendicularly to the surface of the sample. Note the different scales on the x -axes.

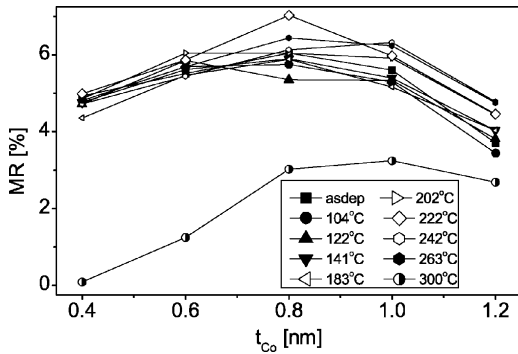


Fig. 2. MR amplitude of $[\text{Ni}_{80}\text{Fe}_{20}(2\text{ nm})/\text{Au}(1.9\text{ nm})/\text{Co}(t_{\text{Co}})/\text{Au}(1.9\text{ nm})]_{10}$ MLs at different stages of the thermal treatment.

In our opinion the small increase of MR amplitude for $222 \leq T_{\text{A}} \leq 263^\circ\text{C}$ is caused by two distinct processes. Firstly, the decrease of H_{N} [compare Fig. 1(a and b)] increases the range of linear change of resistance towards lower fields thus increas-

ing magnetoresistance (see model curve in Ref. [5]). Secondly, the annihilation of defects by thermal processes leads to the reduction of spin-independent scattering and thus increases MR amplitude. It should be emphasized that absence of strong ferromagnetic coupling between NiFe and Co layers (independent reversal [Fig. 1(d and e)]) and the preservation of easy-plane (NiFe) and easy-axis (Co) anisotropies are the main reasons for GMR stability against annealings at $T_{\text{A}} \leq 263^\circ\text{C}$.

In our MLs, contrary to the systems deposited with molecular beam epitaxy [7], annealing in $T_{\text{A}} \leq 263^\circ\text{C}$ leads to an increase of uniaxial anisotropy of Co layers. As the perpendicular anisotropy raises the in-plane saturation field of investigated MLs monotonically increases with T_{A} [Fig. 3(a)]. Their effective magnetic anisotropy can be described by the following expression (compare [8]):

$$K_{\text{eff}} = \frac{2K_{\text{Is}}}{t_{\text{Co}}} + K_{\text{1v}} \quad (1)$$

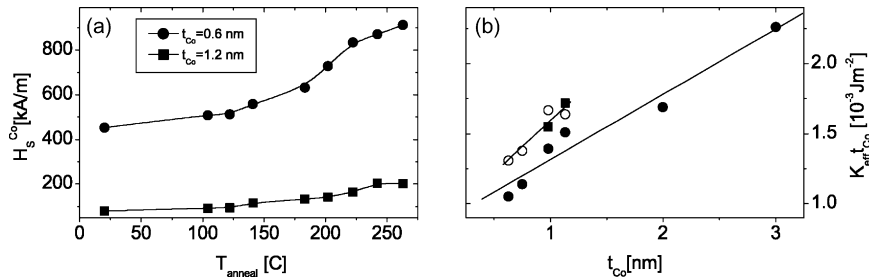


Fig. 3. (a) The in-plane saturation field of Co layers, determined from $M(H)$ dependencies, in $[\text{Ni}_{80}\text{Fe}_{20}(2\text{ nm})/\text{Au}(1.9\text{ nm})/\text{Co}(t_{\text{Co}})/\text{Au}(1.9\text{ nm})]_{10}$ MLs as a function of T_{A} . (b) The product of the effective perpendicular anisotropy and Co layers thickness vs. Co layer thickness [determined for MLs as in (a)] for as-deposited samples (full dots) and after annealing at 263°C (empty dots). The perpendicular surface anisotropy constant is $4.24 \times 10^{-4}\text{ J m}^{-2}$ and the volume anisotropy is $466 \times 10^3\text{ J m}^{-3}$ for as-deposited MLs (for annealed MLs the values are $4.23 \times 10^{-4}\text{ J m}^{-2}$ and $748 \times 10^3\text{ J m}^{-3}$, respectively). The lines are linear fits. Squares in (b) relate to $T_{\text{A}} = 300^\circ\text{C}$.

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